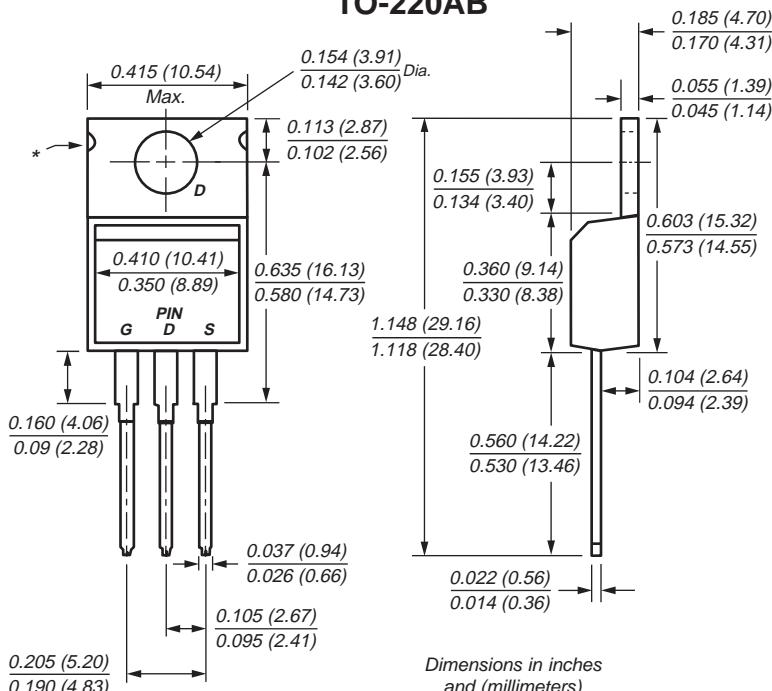


N-Channel Enhancement-Mode MOSFET

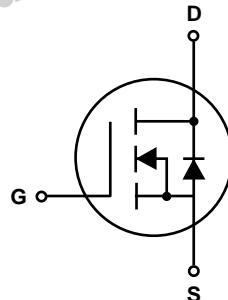
V_{DS} 30V R_{DS(ON)} 11mΩ I_D 60A

**TRENCH
GENFET®**
New Product

TO-220AB



* May be notched or flat



Features

- Advanced Trench Process Technology
- High Density Cell Design for Ultra Low On-Resistance
- Specially Designed for Low Voltage DC/DC Converters
- Fast Switching for High Efficiency

Mechanical Data

Case: JEDEC TO-220AB molded plastic body

Terminals: Leads solderable per MIL-STD-750, Method 2026

High temperature soldering guaranteed:
250°C/10 seconds at terminals

Mounting Torque: 10 in-lbs maximum

Weight: 2.0g

Maximum Ratings and Thermal Characteristics (T_C = 25°C unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V _{DS}	30	V
Gate-Source Voltage	V _{GS}	±20	
Continuous Drain Current ⁽¹⁾	I _D	60	A
Pulsed Drain Current	I _{DM}	100	
Maximum Power Dissipation	P _D	62.5 25	W
Operating Junction and Storage Temperature Range	T _J , T _{stg}	-55 to 150	°C
Lead Temperature (1/8" from case for 5 sec.)	T _L	275	°C
Junction-to-Case Thermal Resistance	R _{θJC}	2.0	°C/W
Junction-to-Ambient Thermal Resistance	R _{θJA}	62.5	°C/W

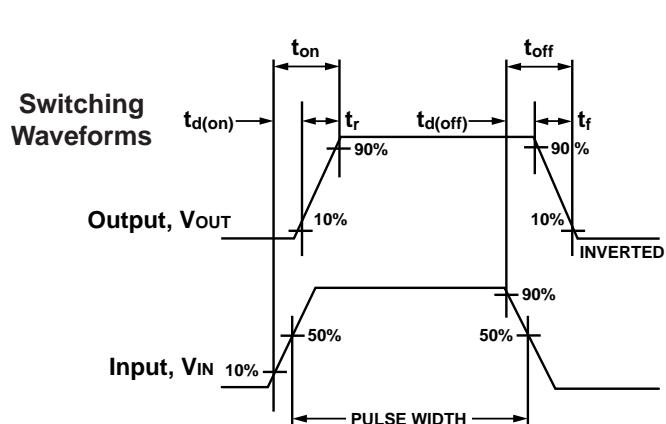
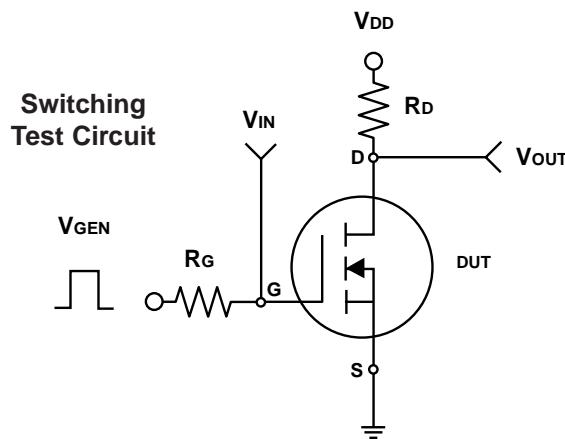
Notes: (1) Maximum DC current limited by the package

N-Channel Enhancement-Mode MOSFET
Electrical Characteristics ($T_J = 25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Static						
Drain-Source Breakdown Voltage	BV_{DSS}	$\text{V}_{\text{GS}} = 0\text{V}, \text{I}_D = 250\mu\text{A}$	30			V
Gate Threshold Voltage	$\text{V}_{\text{GS(th)}}$	$\text{V}_{\text{DS}} = \text{V}_{\text{GS}}, \text{I}_D = 250\mu\text{A}$	1.0		3.0	
Gate-Body Leakage	I_{GSS}	$\text{V}_{\text{DS}} = 0\text{V}, \text{V}_{\text{GS}} = \pm 20\text{V}$			± 100	nA
Zero Gate Voltage Drain Current	I_{DSS}	$\text{V}_{\text{DS}} = 30\text{V}, \text{V}_{\text{GS}} = 0\text{V}$			1	μA
On-State Drain Current ⁽¹⁾	$\text{I}_{\text{D(on)}}$	$\text{V}_{\text{DS}} \geq 5\text{V}, \text{V}_{\text{GS}} = 10\text{V}$	60			A
Drain-Source On-State Resistance ⁽¹⁾	$\text{R}_{\text{DS(on)}}$	$\text{V}_{\text{GS}} = 10\text{V}, \text{I}_D = 30\text{A}$		9	11	$\text{m}\Omega$
		$\text{V}_{\text{GS}} = 4.5\text{V}, \text{I}_D = 25\text{A}$		13	16	
Forward Transconductance ⁽¹⁾	g_{fs}	$\text{V}_{\text{DS}} = 10\text{V}, \text{I}_D = 25\text{A}$		40		S
Diode Forward Voltage	V_{SD}	$\text{I}_S = 25\text{A}, \text{V}_{\text{GS}} = 0\text{V}$		0.9	1.3	V
Dynamic⁽¹⁾						
Total Gate Charge	Q_g	$\text{V}_{\text{DS}} = 15\text{V}, \text{V}_{\text{GS}} = 5\text{V}, \text{I}_D = 50\text{A}$		16	22	nC
Gate-Source Charge	Q_{gs}	$\text{V}_{\text{DS}} = 15\text{V}, \text{V}_{\text{GS}} = 10\text{V}$ $\text{I}_D = 50\text{A}$		35	60	
Gate-Drain Charge	Q_{gd}			8		
Turn-On Delay Time	$\text{t}_{\text{d(on)}}$			6		
Rise Time	t_r	$\text{V}_{\text{DD}} = 15\text{V}, \text{R}_L = 15\Omega$ $\text{I}_D \approx 1\text{A}, \text{V}_{\text{GEN}} = 10\text{V}$ $\text{R}_G = 6\Omega$		11	20	ns
Turn-Off Delay Time	$\text{t}_{\text{d(off)}}$			11	20	
Fall Time	t_f			48	80	
Input Capacitance	C_{iss}			15	30	
Output Capacitance	C_{oss}	$\text{V}_{\text{DS}} = 15\text{V}$ $f = 1.0\text{MHz}$		1850	—	pF
Reverse Transfer Capacitance	C_{rss}			315	—	
Source-Drain Reverse Recovery Time	t_{rr}	$\text{I}_F = 25\text{A}, \frac{\text{d}i}{\text{d}t} = 100\text{A}/\mu\text{s}$		145	—	
				160		ns

Note:

(1) Pulse test; pulse width $\leq 300\ \mu\text{s}$, duty cycle $\leq 2\%$



N-Channel Enhancement-Mode MOSFET

Ratings and Characteristic Curves (TA = 25°C unless otherwise noted)

Fig. 1 – Output Characteristics

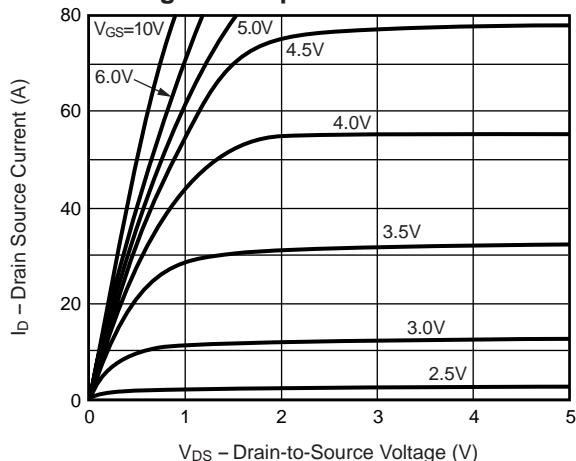


Fig. 2 – Transfer Characteristics

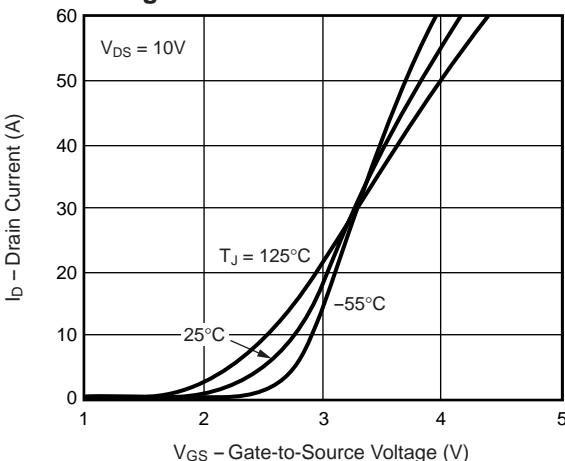


Fig. 3 – Threshold Voltage vs. Temperature

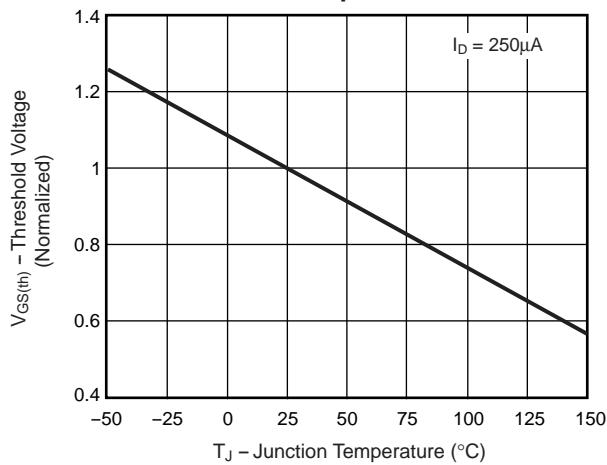


Fig. 4 – On-Resistance vs. Drain Current

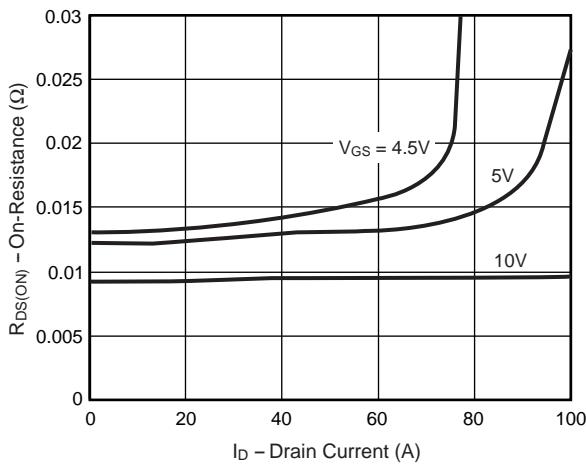
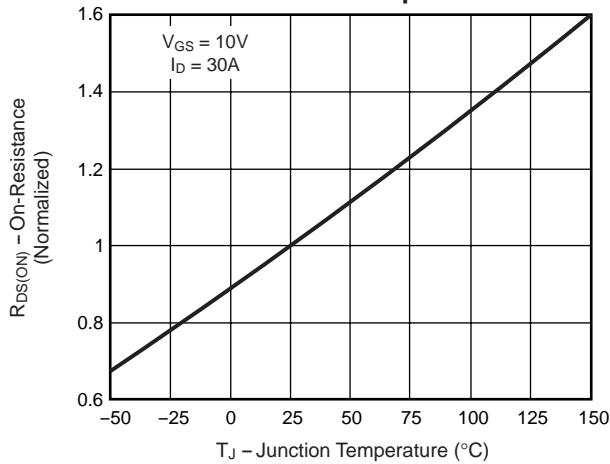


Fig. 5 – On-Resistance vs. Junction Temperature



N-Channel Enhancement-Mode MOSFET

Ratings and Characteristic Curves ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Fig. 6 – On-Resistance vs. Gate-to-Source Voltage

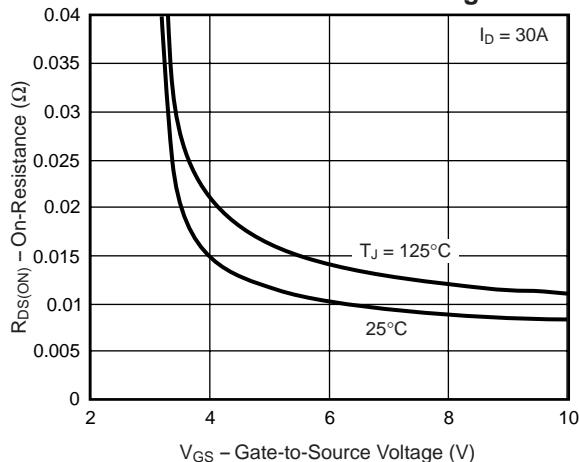


Fig. 7 – Gate Charge

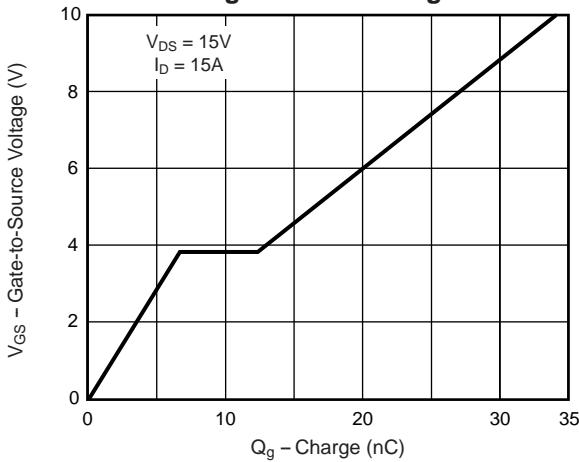


Fig. 8 – Capacitance

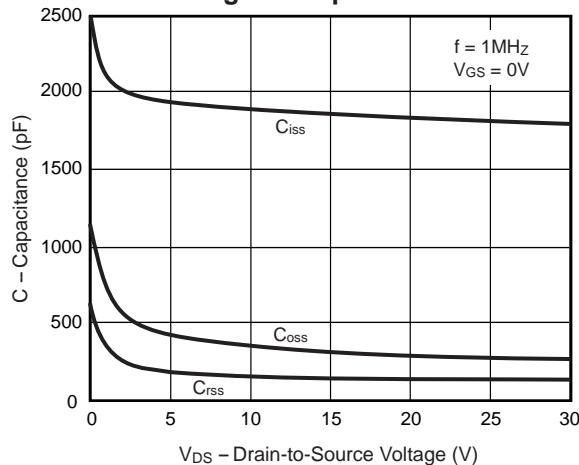
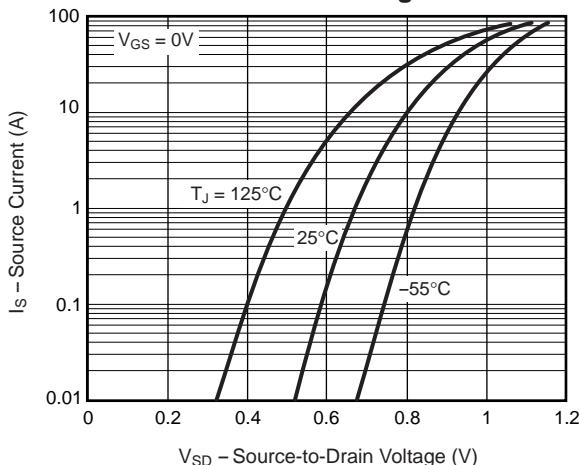


Fig. 9 – Source-Drain Diode Forward Voltage



N-Channel Enhancement-Mode MOSFET

Ratings and Characteristic Curves ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Fig. 10 – Breakdown Voltage vs. Junction Temperature

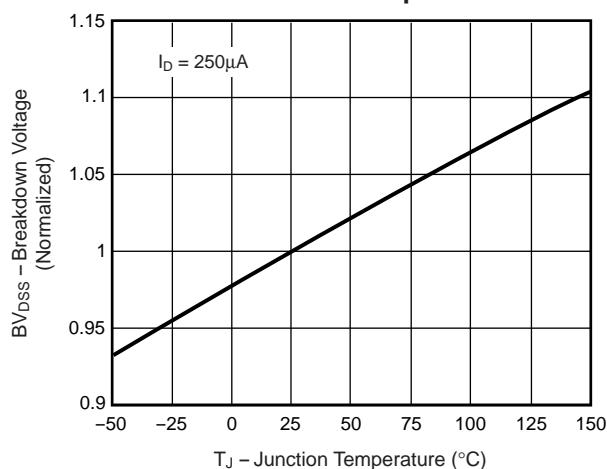


Fig. 11 – Transient Thermal Impedance

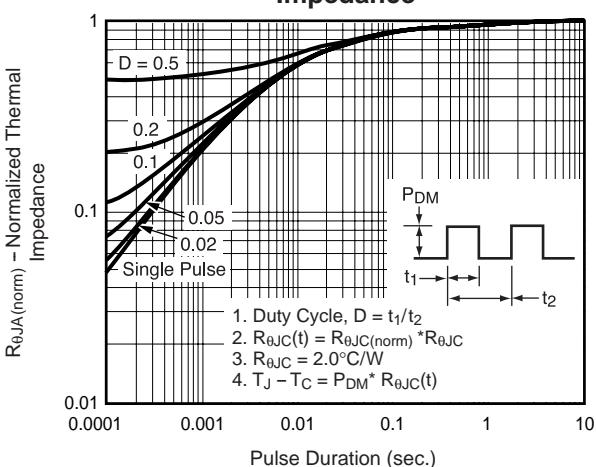


Fig. 12 – Power vs. Pulse Duration

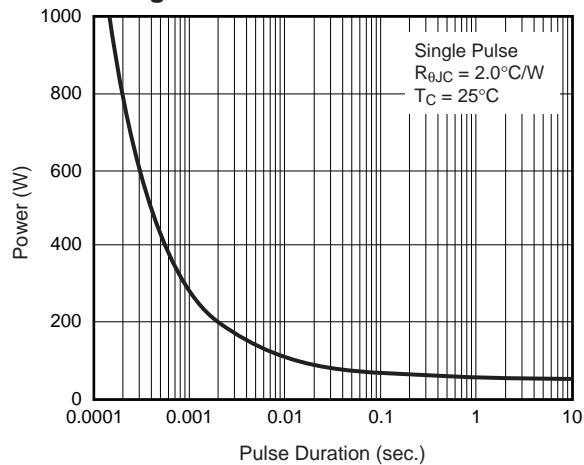


Fig. 13 – Maximum Safe Operating Area

